

Model assessment

Fit ARIMA model: get (essentially automatically) fitted residuals $\hat{\epsilon}$.

Usually: fewer than T residuals

Parameter estimates consistent (if model fitted correct) so fitted residuals should be essentially the true ϵ_t which is white noise.

Assess this by plotting estimated ACF of $\hat{\epsilon}$; see if estimates are all close enough to 0 to pass for white noise.

To judge close enough we need asymptotic distribution theory for autocovariance estimates.

Asymptotic distribution theory for the sample autocorrelation function

Let ρ_k and $\hat{\rho}_k$ be ACF and estimated ACF respectively.

Step 1: reduce behaviour of $\hat{\rho}_k$ to behaviour of \hat{C} , the sample autocovariance.

Our approach is standard Taylor expansion.

Large sample theory for ratio estimates

Suppose you have pairs (X_n, Y_n) of random variables with

$$n^{1/2}(X_n - \mu) \Rightarrow N(0, \sigma^2)$$

and

$$n^{1/2}(Y_n - \nu) \Rightarrow N(0, \tau^2)$$

Study large sample behaviour of X_n/Y_n under assumption $\nu \neq 0$.

Case $\mu = 0$ results in some simplifications.

Begin by writing

$$\frac{X_n}{Y_n} = \frac{X_n}{\nu + (Y_n - \nu)} = \frac{X_n}{\nu} \frac{1}{1 + \epsilon_n}$$

where

$$\epsilon_n = \frac{Y_n - \nu}{\nu}$$

Notice that $\epsilon_n \rightarrow 0$ in probability. We may expand

$$\frac{1}{1 + \epsilon_n} = \sum_{k=0}^{\infty} (-\epsilon_n)^k$$

and then write

$$\frac{X_n}{Y_n} = \frac{X_n}{\nu} \sum_{k=0}^{\infty} (-\epsilon_n)^k$$

We want to compute the mean of this expression term by term and the variance by using the formula for the variance of the sum and so on.

But: really truncate infinite sum at some finite number of terms and compute moments of finite sum.

Example: to illustrate distinction.

Imagine that (X_n, Y_n) has a bivariate normal distribution with means μ, ν , variances σ^2/n , τ^2/n and correlation ρ between X_n and Y_n .

The quantity X_n/Y_n does not have a well defined mean because $E(|X_n/Y_n|) = \infty$.

Our expansion is still valid, however.

Stopping the sum at $k = 1$ leads to the approximation

$$\begin{aligned} \frac{X_n}{Y_n} &\approx \frac{X_n}{\nu} - \frac{X_n(Y_n - \nu)}{\nu^2} \\ &= \frac{X_n}{\nu} - \frac{\mu(Y_n - \nu)}{\nu^2} - \frac{(X_n - \mu)(Y_n - \nu)}{\nu^2} \end{aligned}$$

Look at these terms: which are big and which are small?

Introduce big O notation:

Defn: If U_n is a sequence of random variables and $a_n > 0$ a sequence of constants then we write

$$U_n = O_P(a_n)$$

if, for each $\epsilon > 0$ there is an M (depending on ϵ but not n) such that

$$P(|U_n| > M|a_n|) < \epsilon$$

The idea is that $U_n = O_P(a_n)$ means that U_n is proportional in size to a_n with the “constant of proportionality” being a random variable which is not likely to be too large.

We also often have use for notation indicating that U_n is actually small compared to a_n .

Defn: We say $U_n = o_P(a_n)$ if $U_n/a_n \rightarrow 0$ in probability: for each $\epsilon > 0$

$$\lim_{n \rightarrow \infty} P(|U_n/a_n| > \epsilon) = 0$$

You can manipulate O_P and o_P notation algebraically with a few rules:

- 1) If b_n is a sequence of constants such that $b_n = ca_n$ with $c > 0$ then

$$U_n = O_P(b_n) \Leftrightarrow U_n = O_P(a_n)$$

We write

$$cO_P(a_n) = O_P(a_n)$$

- 2) If $U_n = O_P(a_n)$ and $V_n = O_P(b_n)$ for two sequences a_n and b_n then

$$U_n V_n = O_P(a_n b_n)$$

We express this as

$$O_P(a_n) O_P(b_n) = O_P(a_n b_n)$$

- 3) In particular

$$b_n O_P(a_n) = O_P(b_n a_n)$$

- 4) $O_P(a_n) + O_P(b_n) = O_P(\max(a_n, b_n))$

- 5) $c O_P(a_n) = o_P(a_n)$

- 6) $o_P(a_n) O_P(b_n) = o_P(a_n) o_P(b_n) = o_P(a_n b_n)$

- 7) In particular $b_n o_P(a_n) = o_P(b_n a_n)$

- 8) $o_P(a_n) + o_P(b_n) = o_P(\max(a_n, b_n))$

These notions extend Landau's o and O notation to random quantities.

Example: In our ratio example we have

$$X_n = \mu + O_P(n^{-1/2})$$

and

$$Y_n = \nu + O_P(n^{-1/2})$$

In our geometric expansion

$$\epsilon_n^k = O_P(n^{-k/2})$$

Look first at the expansion stopped at $k = 1$. We have

$$\begin{aligned} \frac{X_n}{Y_n} - \frac{\mu}{\nu} &\approx \frac{X_n - \mu}{\nu} - \frac{\mu(Y_n - \nu)}{\nu^2} \\ &\quad - \frac{(X_n - \mu)(Y_n - \nu)}{\nu^2} \\ &= O_P(n^{-1/2}) + O_P(n^{-1/2}) + O_P(n^{-1}) \end{aligned}$$

(The three terms on the RHS of the first line are being described in terms of roughly how big each is.)

If we stop at $k = 2$ we get

$$\begin{aligned} \frac{X_n}{Y_n} - \frac{\mu}{\nu} &\approx \frac{X_n - \mu}{\nu} - \frac{\mu(Y_n - \nu)}{\nu^2} \\ &\quad - \frac{(X_n - \mu)(Y_n - \nu)}{\nu^2} \\ &\quad + \frac{\mu(Y_n - \nu)^2}{\nu^3} + \frac{(X_n - \mu)(Y_n - \nu)^2}{\nu^3} \\ &= O_P(n^{-1/2}) + O_P(n^{-1/2}) + O_P(n^{-1}) \\ &\quad + O_P(n^{-1}) + O_P(n^{-3/2}) \end{aligned}$$

Keeping only terms of order $O_P(n^{-1/2})$ we find

$$\frac{X_n}{Y_n} - \frac{\mu}{\nu} = \frac{X_n - \mu}{\nu} - \frac{\mu(Y_n - \nu)}{\nu^2} + O_P(n^{-1})$$

Take expected values: except for an error of order n^{-1}

$$E(X_n/Y_n) = \mu/\nu$$

WARNING: real meaning – there is a rv which is approximately (neglecting something which is probably proportional in size to n^{-1})

$$\frac{X_n}{Y_n} - \frac{\mu}{\nu}$$

whose expected value is 0.

For normal example: remainder term in expansions (term $O_P(n^{-1})$) is probably small but its expected value is not defined.

To keep terms up to order $O_P(n^{-1})$ we have to keep terms out to $k = 2$. In general

$$X_n \epsilon_n^k = \left\{ \mu + O_P(n^{-1/2}) \right\} O_P(n^{-k/2}).$$

For $k > 2$ this is $o_P(n^{-1})$ but for $k = 2$ the $\mu O_P(n^{-1})$ term is not negligible. If we retain terms out to $k = 2$ then we get

$$\begin{aligned} \frac{X_n}{Y_n} - \frac{\mu}{\nu} &= \frac{X_n - \mu}{\nu} - \frac{\mu(Y_n - \nu)}{\nu^2} \\ &\quad - \frac{(X_n - \mu)(Y_n - \nu)}{\nu^2} + \frac{\mu(Y_n - \nu)^2}{\nu^3} + O_P(n^{-3/2}) \end{aligned}$$

Taking expected values here we get

$$\begin{aligned} \mathbb{E} \left[\frac{X_n}{Y_n} - \frac{\mu}{\nu} \right] &\approx -\mathbb{E} [(X_n - \mu)(Y_n - \nu)] / \nu^2 \\ &\quad + \frac{\mu}{\nu^3} \mathbb{E} \{ (Y_n - \nu)^2 \} \end{aligned}$$

up to terms of order n^{-1} .

In the normal case we get

$$\mathbb{E} \left[\frac{X_n}{Y_n} - \frac{\mu}{\nu} \right] \approx -\frac{\rho\sigma\tau}{n\nu^2} + \frac{\mu\tau^2}{n\nu^3}.$$

To compute approximate variance should compute second moment of $X_n/Y_n - \mu/\nu$ and subtract square of first moment. Imagine you had a random variable of the form

$$\sum_{k=1}^{\infty} \frac{W_k}{n^{k/2}}$$

where I assume that the W_k do not depend on n . The mean, taken term by term would be of the form

$$\sum_{k=1}^{\infty} \frac{\eta_k}{n^{k/2}}$$

and the second moment of the form

$$\sum_{j=1}^{\infty} \sum_{k=1}^{\infty} \frac{\mathbb{E}(W_j W_k)}{n^{(j+k)/2}}$$

This leads to a variance of the form

$$\frac{\text{Var}(W_1)}{n} + \frac{2\text{Cov}(W_1, W_2)}{n^{3/2}} + O(n^{-2})$$

Our expansion above gave

$$W_1 = \frac{n^{1/2}(X_n - \mu)}{\nu} - \frac{\mu n^{1/2}(Y_n - \nu)}{\nu^2}$$

and

$$W_2 = -\frac{n^{1/2}(X_n - \mu)n^{1/2}(Y_n - \nu)}{\nu^2} + \frac{\mu[n^{1/2}(Y_n - \nu)]^2}{\nu^3}$$

from which we get the approximate variance

$$\left(\frac{\sigma^2}{\nu^2} + \frac{\mu^2 \tau^2}{\nu^4} - 2 \frac{\rho \sigma \tau \mu}{\nu^3} \right) / n + O(n^{-3/2}).$$

Apply these ideas to estimation of ρ_k .

Make X_n be $\hat{C}(k)$ and Y_n be $\hat{C}(0)$.

Replace n by T .

Our first order approximation to $\hat{\rho} - \rho$ is

$$W_1 = T^{1/2}\{\hat{C}(k) - C(k)\}/C(0) \\ - T^{1/2}C(k)\{\hat{C}(0) - C(0)\}/C^2(0).$$

Second order approximation is $W_1 + W_2$ with

$$W_2 = \left[T^{1/2}\{\hat{C}(k) - C(k)\}\right]^2 C(k)/C^3(0) \\ - T^{1/2}\{\hat{C}(k) - C(k)\}T^{1/2}\{\hat{C}(0) - C(0)\}/C^2(0).$$

Now evaluate means and variances in special case where \hat{C} has been calculated using a known mean of 0. That is

$$\hat{C}(k) = \frac{1}{T} \sum_0^{T-1-k} X_t X_{t+k}$$

Then

$$E\{\hat{C}(k) - C(k)\} = -kC(k)/T$$

so

$$E(W_1) = -k\rho_k/T^{1/2}$$

Compute variance: start with second moment:

$$\frac{1}{T^2} \sum_s \sum_t \mathbb{E}(X_s X_{s+k} X_t X_{t+k})$$

Notice: expectations in question involve fourth order product moments of X .

They depend on distribution of X 's and not just on C_X .

For white noise can compute expected value.

For $k > 0$ may assume $s < t$ or $s = t$ since $s > t$ cases can be figured out by swapping s and t in $s < t$ case.

For $s < t$, X_s is independent of all 3 of X_{s+k} , X_t and X_{t+k} .

So expectation factors into something containing the factor $\mathbb{E}(X_s) = 0$.

For $s = t$, we get $E(X_s^2)E(X_{s+k}^2) = \sigma^4$.

So second moment is

$$\frac{T-k}{T^2}\sigma^4$$

This is also the variance since, for $k > 0$ and for white noise, $C_X(k) = 0$.

For $k = 0$ and $s < t$ or $s > t$ the expectation is simply σ^4 .

For $s = t$ we get $E(X_t^4) \equiv \mu_4$.

So variance of sample variance (when mean is known to be 0) is

$$\frac{T-1}{T}\sigma^4 + \mu_4/T - \sigma^4 = (\mu_4 - \sigma^4)/T.$$

For the normal distribution the fourth moment μ_4 is given simply by $3\sigma^4$.

Next: large sample distribution theory.

For $k = 0$ the usual central limit theorem applies to $\sum X_t^2/T$ (in the case of white noise) to prove that

$$\sqrt{T}\{\hat{C}_X(0) - \sigma^2\}/\sqrt{\mu_4 - \sigma^4} \rightarrow N(0, 1).$$

Presence of μ_4 in formula shows approximation quite sensitive to assumption of normality.

For $k > 0$ need “ m -dependent central limit theorem” which shows

$$\sqrt{T}\hat{C}_X(k)/\sigma^2 \rightarrow N(0, 1).$$

In each of these cases the assertion is simply that the statistic in question divided by its standard deviation has an approximate normal distribution.

The sample autocorrelation at lag k is

$$\hat{C}_X(k)/\hat{C}_X(0).$$

For $k > 0$ we can apply Slutsky's theorem to conclude that

$$\sqrt{T}\hat{C}_X(k)/\hat{C}_X(0) \rightarrow N(0, 1).$$

This justifies drawing lines at $\pm 2/\sqrt{T}$ to carry out a 95% test of the hypothesis that the X series is white noise based on the k th sample autocorrelation.

Fact: subtraction of \bar{X} from the observations before computing the sample covariances does not change the large sample approximations, although it does affect the exact formulas for moments.

When the X series is actually not white noise the situation is more complicated.

Consider as an example the model

$$X_t = \phi X_{t-1} + \epsilon_t$$

with ϵ being white noise.

Take

$$\hat{C}_X(k) = \frac{1}{T} \sum_{t=0}^{T-1-k} X_t X_{t+k}$$

to see

$$\begin{aligned} T^2 E(\hat{C}_X(k)^2) \\ = \sum_s \sum_t \sum_{u_1} \sum_{u_2} \sum_{v_1} \sum_{v_2} \phi^{u_1+u_2+v_1+v_2} \\ \times E(\epsilon_{s-u_1} \epsilon_{s+k-u_2} \epsilon_{t-v_1} \epsilon_{t+k-v_2}) \end{aligned}$$

Expectation is 0 unless either all 4 indices on the ϵ 's are the same or the indices come in two pairs of equal values.

First case: requires $u_1 = u_2 - k$ and $v_1 = v_2 - k$ and then $s - u_1 = t - v_1$.

Second case requires one of 3 pairs of equalities: $s - u_1 = t - v_1$ and $s - u_2 = t - v_2$ or $s - u_1 = t + k - v_2$ and $s + k - u_2 = t - v_1$ or $s - u_1 = s + k - u_2$ and $t - v_1 = t + k - v_2$ along with the restriction that the four indices not all be equal.

The actual moment is then μ_4 when all four indices are equal and σ^4 when there are two pairs.

It is now possible to do the sum using geometric series identities and compute the variance of $\hat{C}_X(k)$.

It is not particularly enlightening to finish the calculation in detail.

Fact: for ARMA(p, q) processes can use mixing central limit theorems to conclude that

$$\sqrt{T}\{\hat{C}_X(k) - C_X(k)\}/\sqrt{\text{Var}\{\hat{C}_X(k)\}}$$

has asymptotically a standard normal distribution.

Moreover: same is true when the standard deviation in denominator replaced by an estimate.

To get from this to distribution theory for the sample autocorrelation is easiest when the true autocorrelation is 0.

General tactic: the δ method or Taylor expansion.

For each sample size T you have two estimates, say N_T and D_T of two parameters.

Want distribution theory for the ratio $R_T = N_T/D_T$.

Idea: write $R_T = f(N_T, D_T)$ where $f(x, y) = x/y$; then use fact that N_T and D_T are close to the parameters they estimate.

Here: N_T is sample lag k autocovariance – close to true $C_X(k)$. D_T is sample lag 0 autocovariance, a consistent estimator of $C_X(0)$.

Write

$$\begin{aligned} f(N_T, D_T) &= f\{C_X(k), C_X(0)\} \\ &\quad + \{N_T - C_X(k)\} D_1 f\{C_X(k), C_X(0)\} \\ &\quad + \{D_T - C_X(0)\} D_2 f\{C_X(k), C_X(0)\} \\ &\quad + \text{remainder} \end{aligned}$$

Use a central limit theorem to conclude

$$(\sqrt{T}\{N_T - C_X(k)\}, \sqrt{T}\{D_T - C_X(0)\})$$

has approximately bivariate normal distribution and neglect remainder to get

$$\begin{aligned} \sqrt{T} [f(N_T, D_T) - f\{C_X(k), C_X(0)\}] \\ = \sqrt{T} \{\hat{\rho}(k) - \rho(k)\} \end{aligned}$$

has approximately a normal distribution.

Notation: D_j denotes differentiation with respect to the j th argument of f .

For $f(x, y) = x/y$ we have $D_1 f = 1/y$ and $D_2 f = -x/y^2$.

When $C_X(k) = 0$ the term involving $D_2 f$ vanishes and we simply get the assertion that

$$\sqrt{T}\{\hat{\rho}(k) - \rho(k)\}$$

has the same asymptotic normal distribution as $\hat{C}_X(k)/C_X(0)$.

Similar ideas can be used for the estimated sample partial ACF.

Portmanteau tests

To test hypothesis that series is white noise using distribution theory just given, need single statistic to base test on.

Rather than pick single value of k : consider a sum of squares or a weighted sum of squares of the $\hat{\rho}(k)$.

A typical statistic is

$$T \sum_{k=1}^K \hat{\rho}^2(k)$$

which, for white noise, has approximately a χ_K^2 distribution. (This fact relies on an extension of the previous computations to conclude that

$$\sqrt{T}(\hat{\rho}(1), \dots, \hat{\rho}(K))$$

has approximately a standard multivariate distribution. This, in turn, relies on computation of the covariance between $\hat{C}(j)$ and $\hat{C}(k)$.)

When the parameters in an $\text{ARMA}(p, q)$ have been estimated by maximum likelihood the degrees of freedom must be adjusted to $K - p - q$.

The resulting test is the Box-Pierce test; a refined version which takes better account of finite sample properties is the Box-Pierce-Ljung test.

S-Plus plots the P -values from these tests for 1 through 10 degrees of freedom as part of the output of *arima.diag*.